

**5-Chloromethyl-3-(3-methoxyphenyl)-  
1,2,4-oxadiazole****Hai-Bo Wang,\* Yue-Qing Pu,  
Jia-Hui Chen and Jin-Tang Wang**

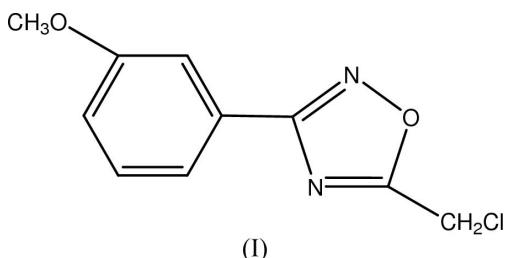
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wanghaibo@njut.edu.cn**Key indicators**

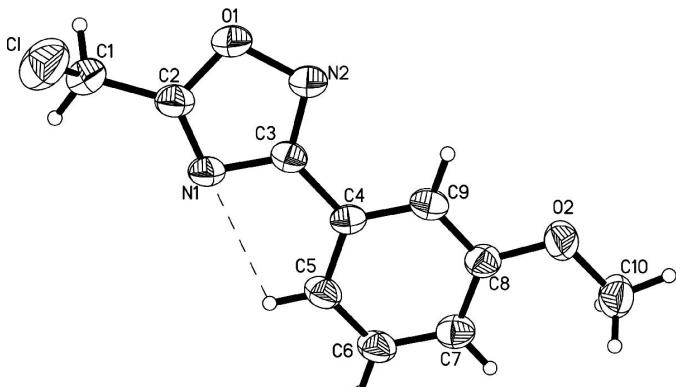
Single-crystal X-ray study

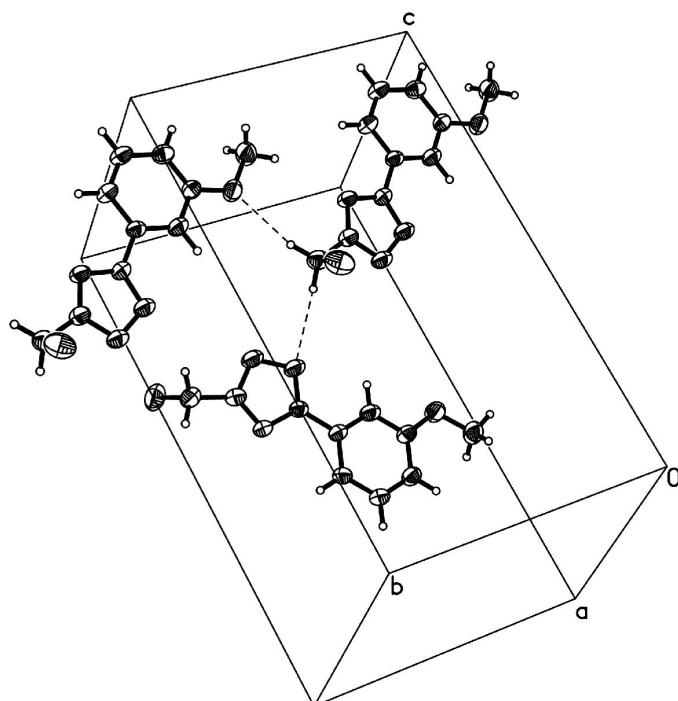
 $T = 293\text{ K}$ Mean  $\sigma(\text{C-C}) = 0.007\text{ \AA}$  $R$  factor = 0.069 $wR$  factor = 0.231

Data-to-parameter ratio = 15.2

For details of how these key indicators were automatically derived from the article, see <http://journals.iucr.org/e>.In the structure of the title compound,  $\text{C}_{10}\text{H}_9\text{ClN}_2\text{O}_2$ , there is a weak intramolecular  $\text{C}-\text{H}\cdots\text{N}$  interaction, and intermolecular  $\text{C}-\text{H}\cdots\text{O}$  and  $\text{C}-\text{H}\cdots\text{N}$  interactions.Received 14 April 2005  
Accepted 18 April 2005  
Online 27 April 2005**Comment**1,2,4-Oxadiazoles are an important class of five-membered heterocycle. Some derivatives of 1,2,4-oxadiazoles have shown intrinsic analgesic (Terashita *et al.*, 2002), anti-inflammatory (Nicolaides *et al.*, 1998) and antipicornaviral (Romero, 2001) properties. We report here the crystal structure of the title compound, (I).The molecular structure of (I) is shown in Fig. 1. Selected bond lengths and angles are given in Table 1. There are weak intermolecular  $\text{C}-\text{H}\cdots\text{O}$  and  $\text{C}-\text{H}\cdots\text{N}$  interactions (Fig. 2 and Table 2). The combination of these and a weak intramolecular  $\text{C}-\text{H}\cdots\text{N}$  interaction generates a three-dimensional network.**Experimental**

A solution of chloroacetyl chloride (14 mmol) in toluene (10 ml) was added dropwise to a solution of 3-methoxybenzamidoxime (14 mmol)

**Figure 1**A view of the molecular structure of (I), showing displacement ellipsoids at the 30% probability level. The dashed line indicates the intramolecular  $\text{C}-\text{H}\cdots\text{N}$  interaction.

**Figure 2**

The crystal structure of (I). Dashed lines indicate the intermolecular C—H···O and C—H···N interactions.

in toluene (60 ml). The resulting mixture was refluxed for 6 h and then concentrated under reduced pressure to afford crude compound (I). Pure compound (I) was obtained by recrystallization from a mixture of ethyl acetate (15 ml) and petroleum ether (7.5 ml). Crystals of (I) suitable for X-ray diffraction were obtained by slow evaporation of an ethanol solution.  $^1\text{H}$  NMR ( $\text{CDCl}_3$ ,  $\delta$ , p.p.m.): 7.66–7.68 (*m*, 1H), 7.59–7.60 (*m*, 1H), 7.37–7.40 (*m*, 1H), 7.05–7.07 (*m*, 1H), 4.74 (*s*, 2H), 3.87 (*s*, 3H).

#### Crystal data

$\text{C}_{10}\text{H}_9\text{ClN}_2\text{O}_2$	$D_x = 1.407 \text{ Mg m}^{-3}$
$M_r = 224.64$	Mo $K\alpha$ radiation
Monoclinic, $P2_1/c$	Cell parameters from 25 reflections
$a = 7.2350 (14) \text{ \AA}$	$\theta = 9\text{--}13^\circ$
$b = 9.5600 (19) \text{ \AA}$	$\mu = 0.34 \text{ mm}^{-1}$
$c = 15.454 (3) \text{ \AA}$	$T = 293 (2) \text{ K}$
$\beta = 97.03 (3)^\circ$	Block, colourless
$V = 1060.9 (4) \text{ \AA}^3$	$0.4 \times 0.3 \times 0.3 \text{ mm}$
$Z = 4$	

#### Data collection

Enraf–Nonius CAD-4 diffractometer	$\theta_{\max} = 26.0^\circ$
$\omega/2\theta$ scans	$h = 0 \rightarrow 8$
Absorption correction: none	$k = 0 \rightarrow 11$
2234 measured reflections	$l = -18 \rightarrow 18$
2066 independent reflections	3 standard reflections every 200 reflections
827 reflections with $I > 2\sigma(I)$	intensity decay: none
$R_{\text{int}} = 0.036$	

#### Refinement

Refinement on  $F^2$   
 $R[F^2 > 2\sigma(F^2)] = 0.069$   
 $wR(F^2) = 0.231$   
 $S = 1.01$   
 2066 reflections  
 136 parameters  
 H-atom parameters constrained

$$w = 1/[c^2(F_o^2) + (0.087P)^2 + 0.5P] \quad \text{where } P = (F_o^2 + 2F_c^2)/3$$

$$(\Delta/\sigma)_{\max} < 0.001$$

$$\Delta\rho_{\max} = 0.21 \text{ e \AA}^{-3}$$

$$\Delta\rho_{\min} = -0.24 \text{ e \AA}^{-3}$$

**Table 1**  
Selected geometric parameters ( $\text{\AA}$ ,  $^\circ$ ).

Cl—C1	1.773 (6)	N1—C2	1.285 (6)
O1—C2	1.348 (6)	N1—C3	1.376 (6)
O1—N2	1.407 (6)	N2—C3	1.294 (6)
O2—C8	1.363 (6)	C1—C2	1.465 (8)
O2—C10	1.440 (6)	C3—C4	1.470 (7)
C2—O1—N2	105.8 (4)	N2—C3—N1	114.0 (5)
C8—O2—C10	117.4 (4)	N2—C3—C4	123.3 (5)
C2—N1—C3	103.3 (4)	N1—C3—C4	122.8 (4)
C3—N2—O1	104.0 (4)	C9—C4—C3	120.3 (5)
C2—C1—Cl	109.7 (4)	C5—C4—C3	120.0 (5)
N1—C2—O1	112.9 (5)	O2—C8—C9	116.2 (5)
N1—C2—C1	129.2 (5)	O2—C8—C7	124.6 (5)
O1—C2—C1	117.9 (5)		

**Table 2**  
Hydrogen-bond geometry ( $\text{\AA}$ ,  $^\circ$ ).

$D—H \cdots A$	$D—H$	$H \cdots A$	$D \cdots A$	$D—H \cdots A$
$\text{Cl}—\text{H}1B \cdots \text{O}2^i$	0.97	2.45	3.393 (4)	166
$\text{Cl}—\text{H}1C \cdots \text{N}2^{ii}$	0.97	2.54	3.471 (4)	161
$\text{C}5—\text{H}5A \cdots \text{N}1$	0.93	2.60	2.912 (4)	100

Symmetry codes: (i)  $x, y - 1, z$ ; (ii)  $-x, y - \frac{1}{2}, -z + \frac{1}{2}$ .

All H atoms were positioned geometrically, with C—H distances in the range 0.93–0.97  $\text{\AA}$ , and included in the refinement in a riding-model approximation, with  $U_{\text{iso}}(\text{H}) = 1.2$  or  $1.5U_{\text{eq}}$  of the carrier atom.

Data collection: *CAD-4 Software* (Enraf–Nonius, 1989); cell refinement: *CAD-4 Software*; data reduction: *XCAD4* (Harms & Wocadlo, 1995); program(s) used to solve structure: *SHELXS97* (Sheldrick, 1997); program(s) used to refine structure: *SHELXL97* (Sheldrick, 1997); molecular graphics: *SHELXTL* (Siemens, 1996); software used to prepare material for publication: *SHELXL97*.

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